MOSFET – Power, Single, N-Channel, μ8FL 30 V, 27 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

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Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage	V_{GS}	±20	V		
Continuous Drain		T _A = 25°C	I _D	7.7	Α
Current R _{θJA} (Note 1)		T _A = 85°C	1	5.8	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	1.63	W
Continuous Drain		T _A = 25°C	I _D	12.2	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 85°C		9.1	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	4.1	W
Continuous Drain	State	T _A = 25°C	I _D	5.0	Α
Current R _{θJA} (Note 2)		T _A = 85°C	1	3.8	
Power Dissipation R _{0JA} (Note 2)		T _A = 25°C	P _D	0.69	W
Continuous Drain		T _C = 25°C	I _D	27	Α
Current R _{θJC} (Note 1)		T _C = 85°C	1	20	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	20.2	W
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	81	Α
Operating Junction and S	T _J , T _{stg}	-55 to +150	°C		
Source Current (Body Did	I _S	17	Α		
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, I _L = 16 A _{pk} , L = 0.1 mH, R _G = 25 Ω) (Note 3)			E _{AS}	13	mJ
Lead Temperature for So (1/8" from case for 10 s)	T _L	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

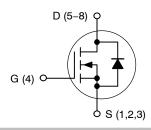


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX
30 V	17 mΩ @ 10 V	27 A
	26.5 mΩ @ 4.5 V	217

N-Channel MOSFET





VDFN8 (μ8FL) CASE 511AB



D

4C25 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week

G [

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4C25NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS4C25NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

3. This is the absolute maximum rating. Parts are 100% tested at T_J = 25°C, $V_{GS} = 10 \text{ V}, I_L = 11 \text{ Apk}, E_{AS} = 6 \text{ mJ}.$

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	6.2	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	76.7	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	210	°C/ VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{ heta JA}$	30.8	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				<u> </u>			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			٧
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	$V_{GS} = 0 \text{ V}, I_{D(aval)} = 4.4 \text{ A},$ $T_{case} = 25^{\circ}\text{C}, t_{transient} = 100 \text{ ns}$		34			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				15.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$				1.0	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.3		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.5		mV/°C
Drain-to-Source On Resistance	On Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}$ $I_D = 10$		I _D = 10 A		13	17	0
		V _{GS} = 4.5 V	I _D = 9 A		21	26.5	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D = 15 A			23		S
Gate Resistance	R_{G}	T _A = 25°C			1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				500		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	z, V _{DS} = 15 V		295		pF
Reverse Transfer Capacitance	C _{RSS}				85		
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15	5 V, f = 1 MHz		0.170		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 20 A			5.1		
Threshold Gate Charge	Q _{G(TH)}				0.9		. 0
Gate-to-Source Charge	Q_{GS}				1.7		nC
Gate-to-Drain Charge	Q_{GD}				2.7		
Gate Plateau Voltage	V _{GP}				3.3		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V; I _D = 20 A			10.3		nC

SWITCHING CHARACTERISTICS (Note 7)

- 6. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 7. Switching characteristics are independent of operating junction temperatures.

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)				•	•	
Turn-On Delay Time	t _{d(ON)}				8.0		
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS}$	s = 15 V,		32		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 10 \text{ A}, R_G = 3.0 \Omega$			10		ns
Fall Time	t _f				3.0		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 15 A, R_{G} = 3.0 Ω			4.0		ns
Rise Time	t _r				25		
Turn-Off Delay Time	t _{d(OFF)}				13		
Fall Time	t _f				2.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = 10 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.87	1.2	
					0.75		V
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dIS/dt = 100 A/ μ s, I _S = 30 A			18.2		
Charge Time	ta				9.8		ns
Discharge Time	t _b				8.4		
Reverse Recovery Charge	Q _{BB}				5.7		nC

^{6.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
7. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

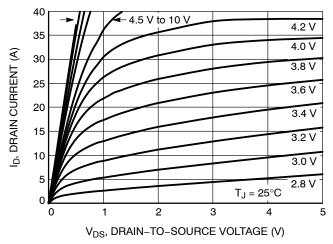


Figure 1. On-Region Characteristics

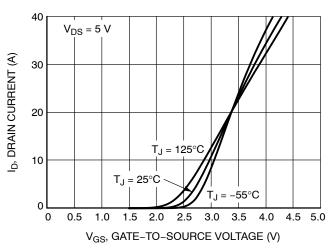


Figure 2. Transfer Characteristics

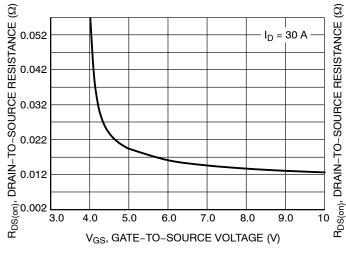


Figure 3. On-Resistance vs. V_{GS}

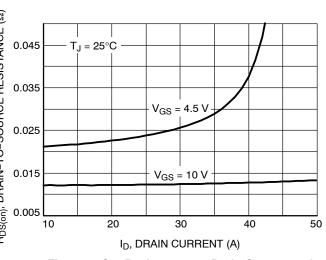


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

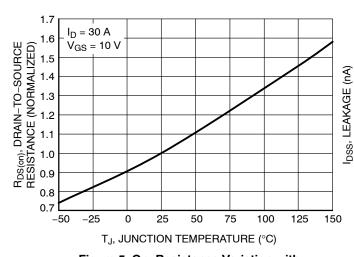


Figure 5. On–Resistance Variation with Temperature

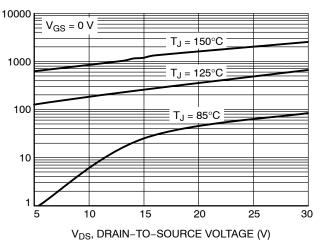


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

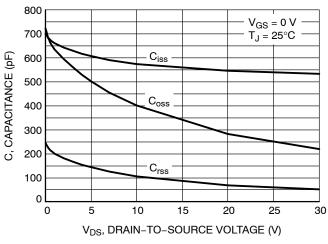


Figure 7. Capacitance Variation

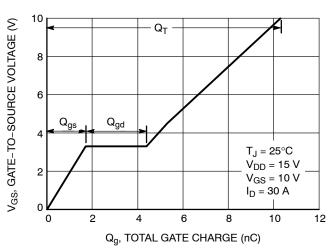


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

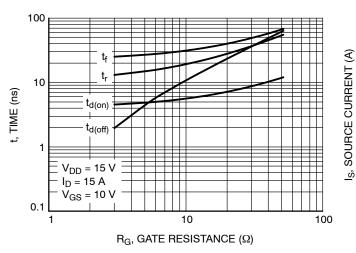


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

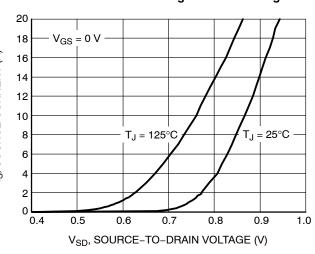


Figure 10. Diode Forward Voltage vs. Current

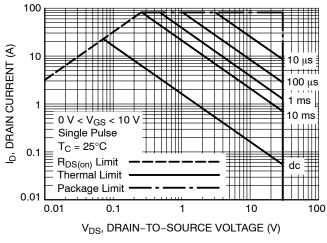


Figure 11. Maximum Rated Forward Biased Safe Operating Area

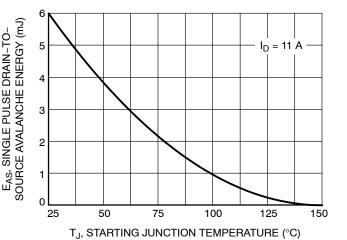


Figure 12. Maximum Avalanche Energy vs. **Starting Junction Temperature**

SINGLE PULSE DRAIN-TO-

TYPICAL CHARACTERISTICS

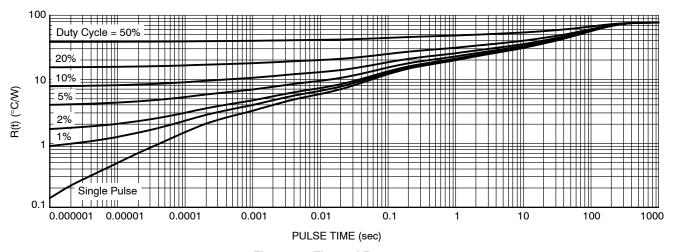


Figure 13. Thermal Response

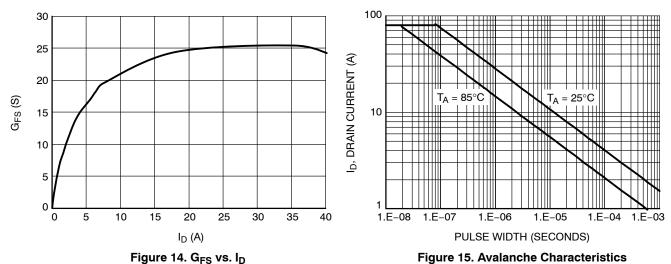


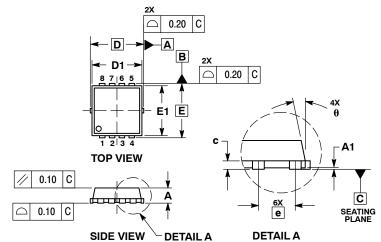
Figure 15. Avalanche Characteristics





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

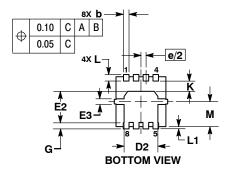
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC			.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

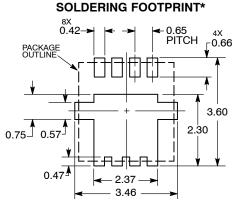


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1		

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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